

<b>Notice of References Cited</b>	Application/Control No.	Applicant(s)/Patent Under Reexamination	
	10/815,193	SHONO, TETSUJI	
	Examiner John M. Villecco	Art Unit 2612	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2005/0207748	09-2005	Ishizuka et al.	396/349
*	B	US-2005/0185950	08-2005	Omiya et al.	396/349
*	C	US-2005/0002665	01-2005	Ito et al.	396/349
*	D	US-6,978,089	12-2005	Nomura et al.	396/75
*	E	US-6,978,088	12-2005	Nomura, Hiroshi	396/350
*	F	US-6,944,396	09-2005	Ito et al.	396/75
*	G	US-6,937,816	08-2005	Endo et al.	396/349
*	H	US-2005/0280903	12-2005	Oshima et al.	359/697
*	I	US-2005/0254140	11-2005	Sakamoto, Takamasa	359/695
*	J	US-2005/0185297	08-2005	Omiya et al.	359/704
*	K	US-2004/0151490	08-2004	Nomura, Hiroshi	396/349
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	X	

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